

N-Ch 60V Fast Switching MOSFETs


- ★ Super Low Gate Charge
- ★ 100% EAS Guaranteed
- ★ Green Device Available
- ★ Excellent CdV/dt effect decline
- ★ Advanced high cell density Trench technology

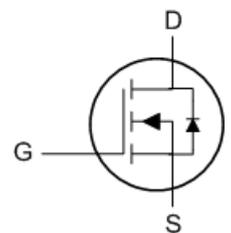
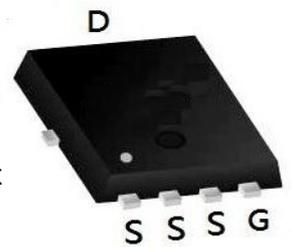
Product Summary

| BVDSS | RDSON | ID |
|-------|-------|-----|
| 60V | 28mΩ | 20A |

Description

The XXW20N06D is the high cell density trenched N-ch MOSFETs, which provide excellent RDSON and gate charge for most of the synchronous buck converter applications.

The XXW20N06D meet the RoHS and Green Product requirement, 100% EAS guaranteed with full function reliability approved.

PDFN3333-8L Pin Configuration

Absolute Maximum Ratings

| Symbol | Parameter | Rating | Units |
|--------------------------|--|------------|------------|
| V_{DS} | Drain-Source Voltage | 60 | V |
| V_{GS} | Gate-Source Voltage | ± 20 | V |
| $I_D @ T_A = 25^\circ C$ | Continuous Drain Current, $V_{GS} @ 10V^1$ | 20 | A |
| $I_D @ T_A = 70^\circ C$ | Continuous Drain Current, $V_{GS} @ 10V^1$ | 10 | A |
| I_{DM} | Pulsed Drain Current ² | 46 | A |
| EAS | Single Pulse Avalanche Energy ³ | 25.5 | mJ |
| I_{AS} | Avalanche Current | 20 | A |
| $P_D @ T_C = 25^\circ C$ | Total Power Dissipation ⁴ | 34.7 | W |
| T_{STG} | Storage Temperature Range | -55 to 150 | $^\circ C$ |
| T_J | Operating Junction Temperature Range | -55 to 150 | $^\circ C$ |

Thermal Data

| Symbol | Parameter | Typ. | Max. | Unit |
|-----------------|--|------|------|--------------|
| $R_{\theta JA}$ | Thermal Resistance Junction-Ambient ¹ | --- | 62 | $^\circ C/W$ |

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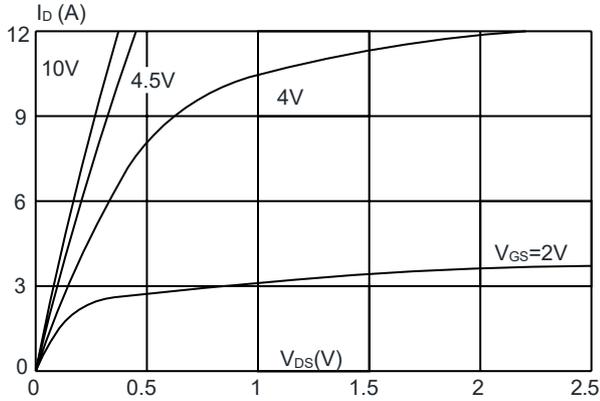
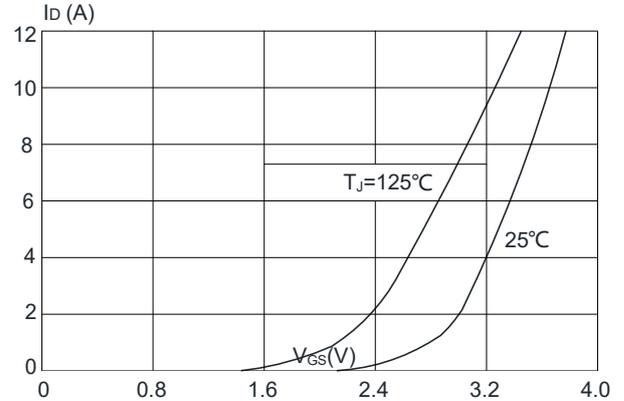
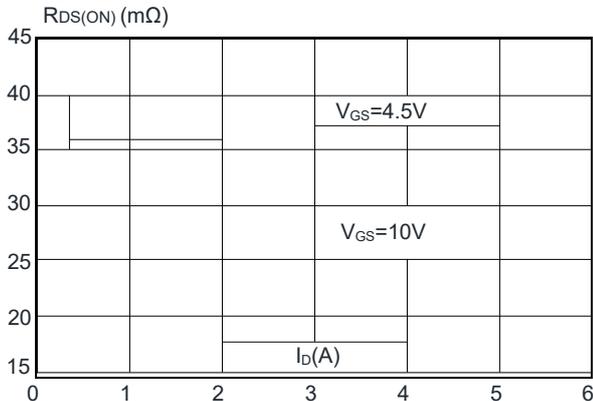
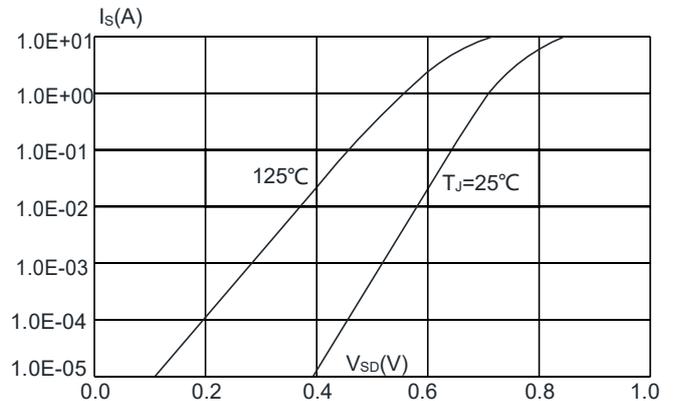
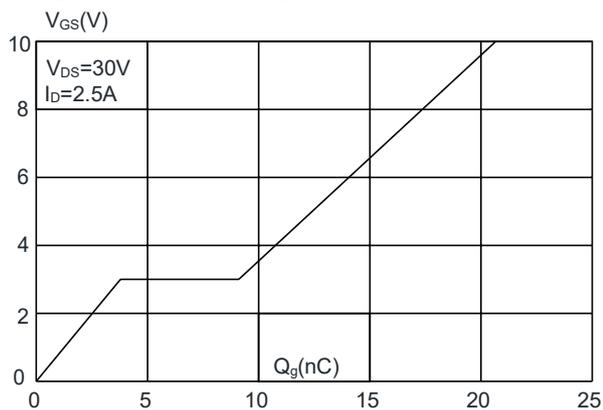
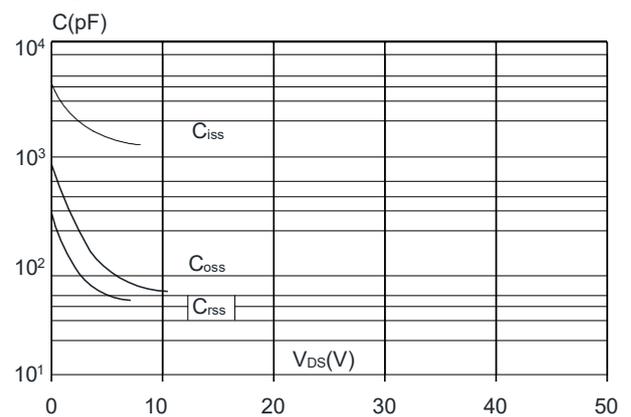
Electrical Characteristics ($T_J=25^{\circ}\text{C}$ unless otherwise specified)

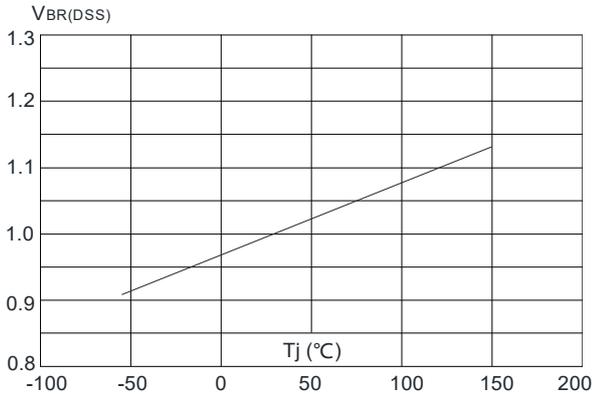
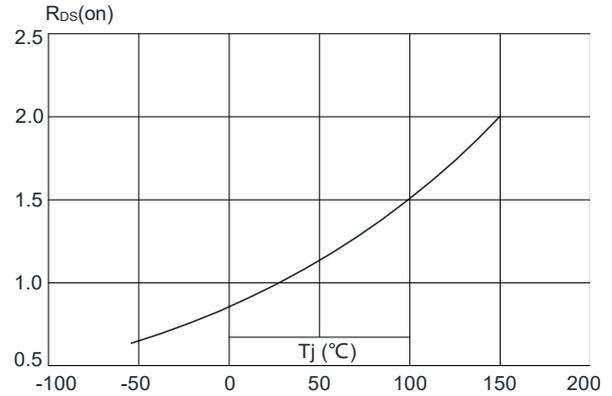
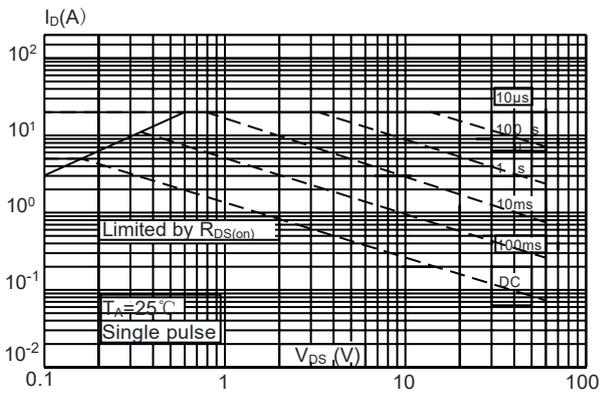
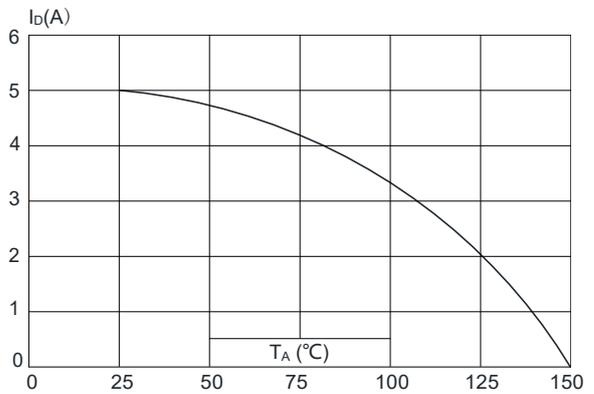
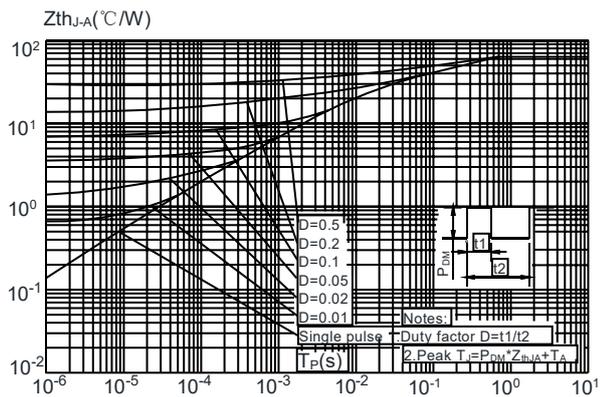
| Symbol | Parameter | Test Condition | Min. | Typ. | Max. | Units |
|---|---|--|------|------|-----------|------------|
| Off Characteristic | | | | | | |
| $V_{(BR)DSS}$ | Drain-Source Breakdown Voltage | $V_{GS}=0V, I_D=250\mu A$ | 60 | - | - | V |
| I_{DSS} | Zero Gate Voltage Drain Current | $V_{DS}=60V, V_{GS}=0V,$ | - | - | 1.0 | μA |
| I_{GSS} | Gate to Body Leakage Current | $V_{DS}=0V, V_{GS}=\pm 20V$ | - | - | ± 100 | nA |
| On Characteristics | | | | | | |
| $V_{GS(th)}$ | Gate Threshold Voltage | $V_{DS}=V_{GS}, I_D=250\mu A$ | 1.0 | 1.6 | 2.5 | V |
| $R_{DS(on)}$ | Static Drain-Source on-Resistance <small>note3</small> | $V_{GS}=10V, I_D=5A$ | - | 28 | 40 | m Ω |
| | | $V_{GS}=4.5V, I_D=3A$ | - | 36 | 50 | |
| Dynamic Characteristics | | | | | | |
| C_{iss} | Input Capacitance | $V_{DS}=25V, V_{GS}=0V,$ $f=1.0\text{MHz}$ | - | 1148 | - | pF |
| C_{oss} | Output Capacitance | | - | 58.5 | - | pF |
| C_{rss} | Reverse Transfer Capacitance | | - | 49.4 | - | pF |
| Q_g | Total Gate Charge | $V_{DS}=30V, I_D=2.5A,$ $V_{GS}=10V$ | - | 20.3 | - | nC |
| Q_{gs} | Gate-Source Charge | | - | 3.7 | - | nC |
| Q_{gd} | Gate-Drain("Miller") Charge | | - | 5.3 | - | nC |
| Switching Characteristics | | | | | | |
| $t_{d(on)}$ | Turn-on Delay Time | $V_{DS}=30V, I_D=5A,$ $R_G=1.8\Omega, V_{GS}=10V$ | - | 7.6 | - | ns |
| t_r | Turn-on Rise Time | | - | 20 | - | ns |
| $t_{d(off)}$ | Turn-off Delay Time | | - | 15 | - | ns |
| t_f | Turn-off Fall Time | | - | 24 | - | ns |
| Drain-Source Diode Characteristics and Maximum Ratings | | | | | | |
| I_S | Maximum Continuous Drain to Source Diode Forward Current | | - | - | 5 | A |
| I_{SM} | Maximum Pulsed Drain to Source Diode Forward Current | | - | - | 20 | A |
| V_{SD} | Drain to Source Diode Forward Voltage | $V_{GS}=0V, I_S=5A$ | - | - | 1.2 | V |
| t_{rr} | Body Diode Reverse Recovery Time | $I_F=5A, di/dt=100A/\mu s$ | - | 29 | - | ns |
| Q_{rr} | Body Diode Reverse Recovery Charge | | - | 43 | - | nC |

Notes: 1. Repetitive Rating: Pulse Width Limited by Maximum Junction Temperature

 2. EAS condition : $T_J=25^{\circ}\text{C}, V_{DD}=30V, V_G=10V, L=0.5\text{mH}, R_G=25\Omega, I_{AS}=8.7A$

 3. Pulse Test: Pulse Width $\leq 300\mu s$, Duty Cycle $\leq 0.5\%$

Typical Performance Characteristics
Figure 1: Output Characteristics

Figure 2: Typical Transfer Characteristics

Figure 3: On-resistance vs. Drain Current

Figure 4: Body Diode Characteristics

Figure 5: Gate Charge Characteristics

Figure 6: Capacitance Characteristics


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Figure 7: Normalized Breakdown Voltage vs. Junction Temperature

Figure 8: Normalized on Resistance vs. Junction Temperature

Figure 9: Maximum Safe Operating Area

Figure 10: Maximum Continuous Drain Current vs. Ambient Temperature

Figure.11: Maximum Effective Transient Thermal Impedance, Junction-to-Ambient


Test Circuit

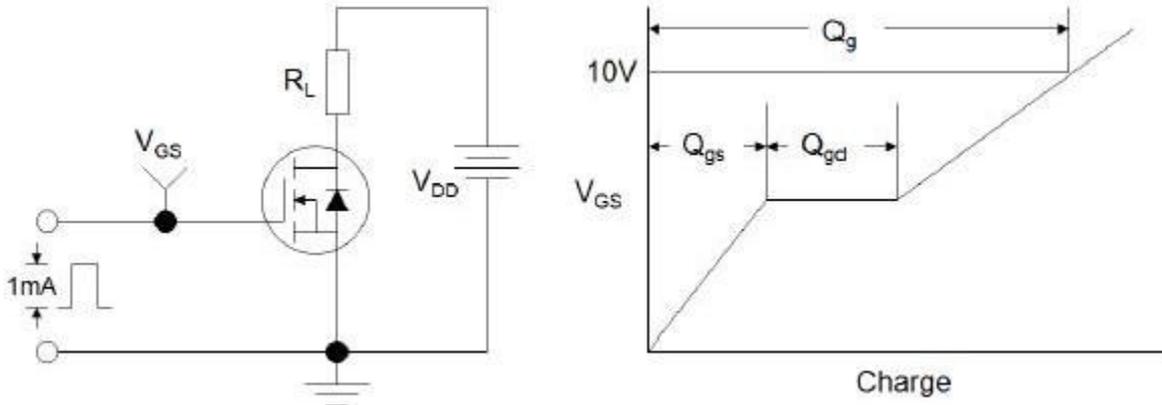


Figure1:Gate Charge Test Circuit & Waveform

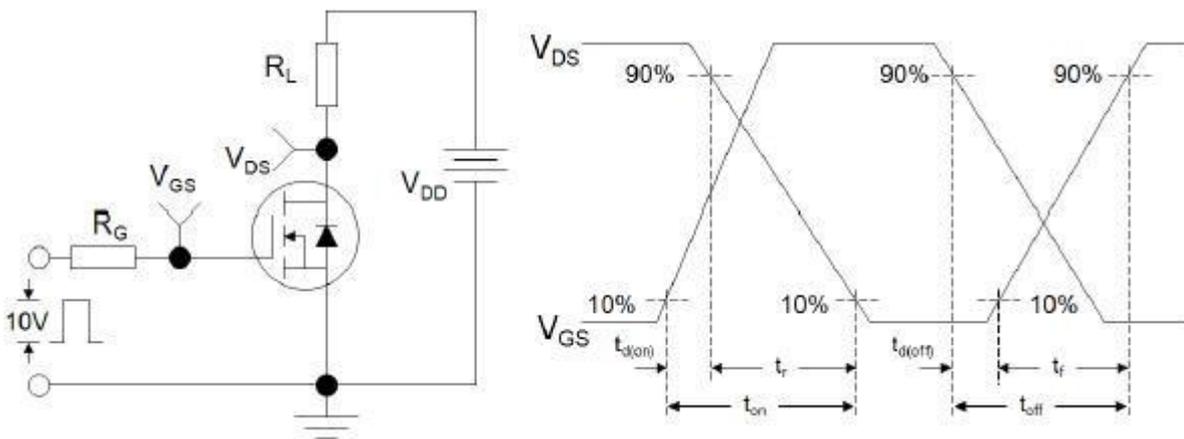


Figure 2: Resistive Switching Test Circuit & Waveforms

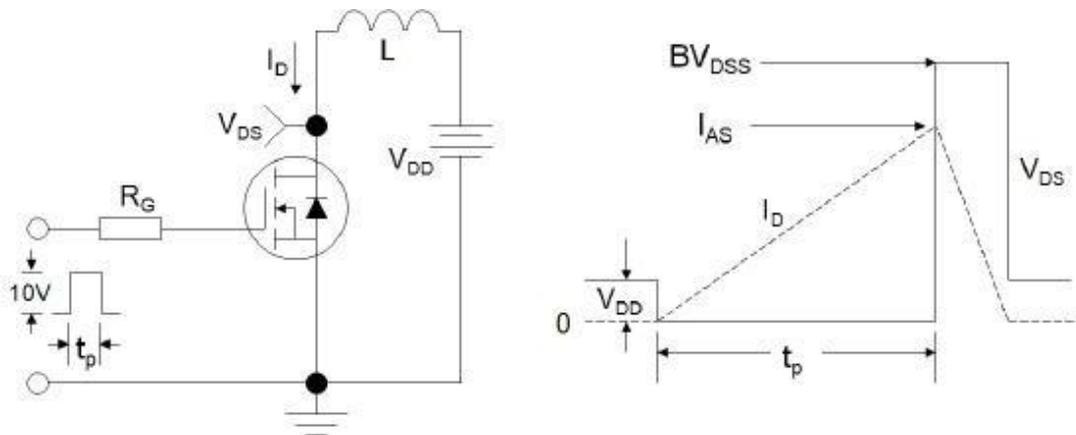
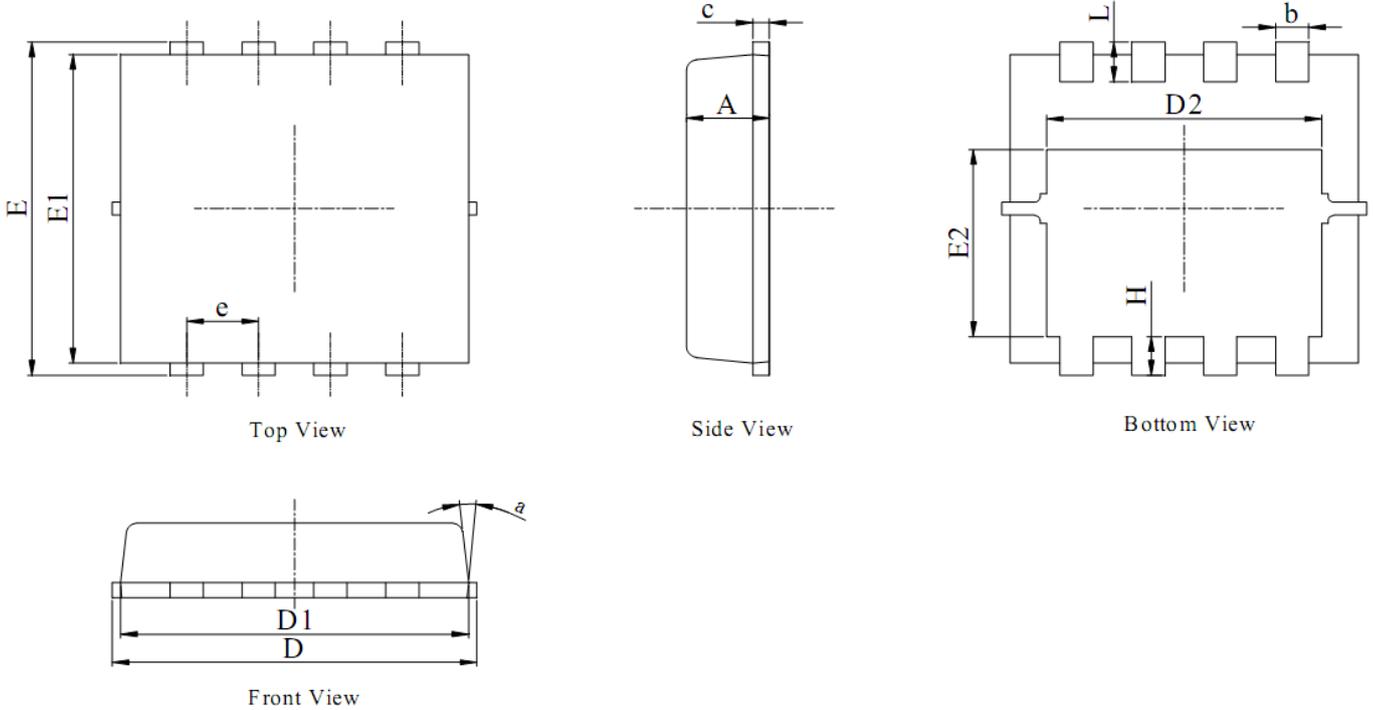
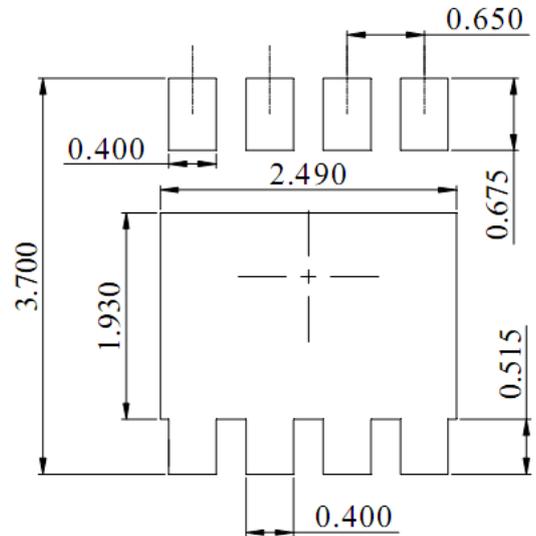


Figure 3:Unclamped Inductive Switching Test Circuit & Waveforms

Package Mechanical Data-PDFN3333-8L-Single

NOTES:

1. DIMENSIONING AND TOLERANCING PER ASME Y14.5M,1994.
2. ALL DIMENSIONS IN MILLIMETER (ANGLE IN DEGREE).
3. DIMENSIONS D1 AND E1 DO NOT INCLUDE MOLD FLASH PROTRUSIONS OR GATE BURRS.

| DIM. | MILLIMETER | | |
|------|------------|------|------|
| | MIN. | NOM. | MAX. |
| A | 0.70 | 0.75 | 0.80 |
| b | 0.25 | 0.30 | 0.35 |
| c | 0.10 | 0.20 | 0.25 |
| D | 3.00 | 3.15 | 3.25 |
| D1 | 2.95 | 3.05 | 3.15 |
| D2 | 2.39 | 2.49 | 2.59 |
| E | 3.20 | 3.30 | 3.40 |
| E1 | 2.95 | 3.05 | 3.15 |
| E2 | 1.70 | 1.80 | 1.90 |
| e | 0.65 BSC | | |
| H | 0.30 | 0.40 | 0.50 |
| L | 0.25 | 0.40 | 0.50 |
| a | --- | --- | 15° |



DIMENSIONS: MILLIMETERS